

Product Change Notification - ASER-30UIEG575

Date:

05 May 2020

Product Category:

Memory

Affected CPNs:



Notification subject:

CCB 3315.003 Final Notice: Qualification of MMT as a new assembly site for selected Atmel products in the AT27xxx device family available in 32L PLCC (11.5x14x3.37mm) package.

Notification text:

PCN Status:

Final notification.

PCN Type:

Manufacturing Change

Microchip Parts Affected:

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of MMT as a new assembly site for selected Atmel products in the AT27xxx device family available in 32L PLCC (11.5x14x3.37mm) package.

Pre Change:

Assembled at LPI assembly site using CRM-1033BF die attach material and Q1-4939 die coat material or assembled at ANAP assembly site using CRM-1076E die attach material and Q3-6646 die coat material.

Post Change:

Assembled at MMT using 3280 die attach material and Q1-4939 die coat material.

Pre and Post Change Summary:

g	Pre C	hange	Post Change
Assembly Site	Lingsen Precision Industires, LTD. (LPI)	Amkor Technology Philippine (P1/P2), INC. (ANAP)	Microchip Technology Thailand (Branch) (MMT)
Wire Material	Au	Au	Au
Die Attach Material	CRM-1033BF	CRM-1076E	3280
Die Coat Material	Q1-4939	Q3-6646	Q1-4939
Molding Compound Material	G600	G600	G600
Lead Frame Material	A194	A194	A194



None.

Change Impact:

None.

Reason for Change:

To improve manufacturability by qualifying MMT as new assembly site.

Change Implementation Status:

In Progress

Estimated First Ship Date:

June 10, 2020 (date code: 2024)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	May 2020			June 2020						
Workweek	18	19	20	21	22	23	24	25	26	27
Qual Report Availability		X								
Final PCN Issue Date		X								
Estimated Implementation Date							Χ			

Method to Identify Change:

Traceability code

Qualification Report:

Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:

May 05, 2020: Issued final notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s):

PCN ASER-30UIEG575 Qual Report(1 of 2).pdf PCN ASER-30UIEG575 Qual Report(2 of 2).pdf

Please contact your local <u>Microchip sales office</u> with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN home page</u> select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to change your PCN profile, including opt out, please go to the PCN home page select



login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

ASER-30UIEG575 - CCB 3315.003 Final Notice: Qualification of MMT as a new assembly site for selected Atmel products in the AT27xxx device family available in 32L PLCC (11.5x14x3.37mm) package.

Affected Catalog Part Numbers (CPN)

AT27BV256-70JU

AT27LV256A-90JU

AT27BV256-70JU-T

AT27LV256A-90JU-T

AT27LV512A-90JU

AT27LV512A-90JU-T

AT27BV010-90JU

AT27LV010A-70JU

AT27BV010-90JU-T

AT27LV010A-70JU-T

AT27LV020A-12JU

AT27LV020A-12JU-T

AT27C256R-45JU

AT27C256R-70JU

AT27C256R-70JU-306

AT27C256R-45JU-T

AT27C256R-70JU-T

AT27C512R-45JU

AT27C512R-70JU

AT27C512R-45JU-T

AT27C512R-70JU-T

AT27C020-55JU

AT27C020-90JU

AT27C020-55JU-T

AT27C020-90JU-T

Date: Tuesday, May 05, 2020



QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN #: ASER-30UIEG575

Date: July 9, 2018

Qualification of MMT as a new assembly site for selected Atmel products in the AT27xxx device family available in 32L PLCC (11.5x14x3.37mm) package.



Purpose: Qualification of MMT as a new assembly site for selected Atmel

products in the AT27xxx device family available in 32L PLCC

(11.5x14x3.37mm) package.

CCB Number: 3315.003

	CN	ES184659-25367
	Assembly site	MMT
Misc.	BD Number	BDM-001712 rev A
	MP Code (MPC)	340357T2XC01
	Part Number (CPN)	AT27BV1024-90JU
	Paddle size	230x230 mils
	Material	CDA151
	Surface	Ag Spot Plated
Lood Frama	Treatment	None
<u>Lead-Frame</u>	Process	Stamped
	Lead-lock	No
	Part Number	10104409
	Lead Plating	Matte Tin
Bond Wire	Material	Au
Die Attach	Part Number	3280
Die Attach	Conductive	Yes
Die Coat	Part Number	Q1-4939
MC	Part Number	G600V
PKG	PKG Type	PLCC
FNG	Pin/Ball Count	44
	Die Thickness	15 mils
<u>Die</u>	Die Size	139.0x146.0 mils
	Fab Process (site)	34K/MCSO



Manufacturing Information:

Assembly Lot No.	Wafer No.	Date Code
MMT-190100734.000	MCSO518528564.000	18147BC
MMT-190100735.000	MCSO518528564.000	18147BD
MMT-190100736.000	MCSO518528564.000	18147BE

Result	X Pass	Fail		
--------	--------	------	--	--

44L PLCC package for wafer mask 34035 assembled at MMT using Au wire is qualified at Moisture/Reflow Sensitivity Classification Level 1 per IPC/JEDEC J-STD-020D standard. No delamination were observed on all the units.

PACKAGE QUALIFICATION REPORT

Test Number Test Condition Standard/ Qty. Def/SS Result Remarks (Reference) Method (Acc.)

	T				1	1
Price Perform	Electrical Test: +25°C	JESD22- A113	803(0)	0/803		Good Devices
Prior Perform Reliability Tests		AIIS		0/135	Passed	
(At MSL Level 1)	0hr CSAM					
	Bake 150°C, 24 hrs System: HERAEUS		803			
	85°C/85%RH Moisture Soak 168 hrs. System: Climats Excal 5423-HE	IPC/JEDE C J-STD-	803			
	3x Convection-Reflow 245°C max	020D	803			
	System: Mancorp CR.5000F		000		Passed	
	Post CSAM			0/135	rasseu	
	Electrical Test: +25°C			0/803	Passed	
	Otro a Complition (O)					Parts had been
	Stress Condition: (Standard) 65°C to +150°C, 500 Cycles System: VOTSCH VT 7012 S2	JESD22- A104	238			pre-conditioned at 245°C
	Electrical Test: +25°C		238(0)	0/238	Passed	
Temp Cycle	Bond Strength: Wire Pull (> 6.00 grams) Bond Shear (>22.00 grams)		15(0)	0/15	Passed	

PACKAGE QUALIFICATION REPORT									
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks			
	Stress Condition: (Standard) +130°C/85%RH, 96 hrs. System: HIRAYAMA HASTEST PC-422R8	JESD22- A118	248			Parts had been pre-conditioned at 245°C			
UNBIASED- HAST	Electrical Test: +25°C		248(0)	0/248	Passed				
	Stress Condition: (Standard) +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HIRAYAMA HASTEST PC-422R8	JESD22- A110	238			Parts had been pre-conditioned a 245°C			
HAST	Electrical Test: +25°C		238(0)	0/238	Passed				

	PACKAGE QUALIFICATION REPORT									
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks				
High Temperature Storage Life	Stress Condition: Bake 175°C, 504 hrs System: HERAEUS	JESD22- A103	50			50 units				
_	Electrical Test :+25°C		50(0)	0/50	Pass					
Solderability Temp 245°C	Bake: Temp 155°C,4Hrs System:Oven Solder Bath: Temp.245°C Solder material: SnPb Visual Inspection: External Visual Inspection	J-STD-002	15 (0)	0/15	Pass	Performed at MPHIL				
Physical Dimensions	Physical Dimension, 10 units from 3 lot	JESD22- B100/B108	30(0) Units	0/30	Pass					
Bond Strength	Wire Pull (> 6.00 grams)	M2011.8 MIL-STD- 883	30(0) Wires	0/30	Pass					
Data Assembly	Bond Shear (>22.00 grams)	M2011.8 MIL-STD- 883	30(0) bonds	0/30	Pass					



QUALIFICATION REPORT RELIABILITY LABORATORY

PCN #: ASER-30UIEG575

Date November 17, 2014

Qualification of MMT as a new assembly site for selected Atmel products in the AT27xxx device family available in 32L PLCC (11.5x14x3.37mm) package.



Purpose Qualification of MMT as a new assembly site for selected Atmel products in

the AT27xxx device family available in 32L PLCC (11.5x14x3.37mm)

package.

CN BC141258

QUAL ID Q14111

 MP CODE
 640021L4XA00

 Part No.
 HV20220PJ-G

Lot No. MMT-151800412.000 **Bonding No.** BDM-000534 rev F

CCB No.: 3315.003

Package

Type 28L PLCC

Lead Frame

Paddle size 300 x300 mils (ASM-Singapore)

Material A194

Surface Ag Spot Plated

Process Etched
Lead Lock Yes

Part Number 10102833

Treatment None

Die attach material

Epoxy 3280

Wire Au wire (MKE-Korea)

Mold Compound G600V (Sumitomo-Japan)

Plating Composition Matte Tin

Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
MMT-151800412.000	N/A	1431MJE

Result	X	Pass	Fail	

28L PLCC assembled by MMT (ALPH) pass reliability test per Supertex standard qual plan for SMD Package. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 245°C reflow temperature per IPC/JEDEC J-STD-020D standard.

	PACKAGE QUALIFICATION REPORT									
Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/SS	Result	Remarks				
Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 250°C max System: Vitronics Soltec MR1243 (IPC/JEDEC J-STD-020D)	IPC/JED EC J- STD- 020D	25	0/25	Pass					

Bake 150°C, 24 hrs System: CHINEE		250		
85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH		250		
3x Convection-Reflow 250°C max		250		
System: Vitronics Soltec MR1243				
Electrical Test: Post test Supertex Hongkong		0/250	Pass	

PACKAGE QUALIFICATION REPORT								
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks		
TEST 1: ASSEMBLY PROCESS CHARACTERIZATION								
1a. Die Shear	Die Shear (Minimum: 4.0 kgf)	MIL-STD- 883J- M2019.8	5(0)	0/5	Pass			
1b. Bond Shear	Bond Shear (Minimum: 19.00 grams)	JESD22- B116	30 (0) Wires	0/30	Pass			
1c. Wire Bond Pull	Wire Pull (Minimum: 3.0 grams)	MIL-STD- 883J- M2011.9 Condition C or D	30 (0) Wires	0/30	Pass			
TEST 2: FINAL TEST								
Post- Assembly Final Test Yield	Per device spec	Per device spec	1185(0)	21/1185	Pass	Test Location: Supertex Hongkong Note:		
	Electrical Test: Supertex HK	>85% test yield				98% test yield		

PACKAGE QUALIFICATION REPORT							
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks	
TEST 3: PACKAGI	E INTEGRITY AND MECHANICAL TEST						
3a. Visual Examination	Stress Condition: Supertex spec#QCGP-1001	Supertex spec#QCG P-1001	315(0)	0/315	Pass	Test Location: Supertex Hongkong	
3b. Physical Dimension	Stress Condition: Post Assembly	JESD22- B100B	8(0)	0/8	Pass	Test Location: Supertex Hongkong	
3c. Solderability (Tin-alloy)	Stress Condition: 1) Condition C (Tin-alloy):8 hrs. Steam age; 2) Test Method 1:Dip&Look Test; Group 1:Test to SnPb solder (215+/-5 C); Group 2:Test to Pb-free solder (245+/-5C);	JESD22- B102E	8(0) 8(0)	0/8	Pass Pass	Test Location: Supertex Hongkong	

PACKAGE QUALIFICATION REPORT								
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks		
TEST 4: PACKAGE INTEGRITY AND MECHANICAL TEST								
4a. Precondition Prior Perform Reliability Tests (At MSL Level 1)	Stress Condition: -Bake 150°C, 24 hrs System: CHINEE -85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH -3x Convection-Reflow 250°C max System: Vitronics Soltec MR1243 Electrical Test: Post test at Supertex HK	JESD22- A113F	250(0)	0/250	Pass	Test Location: Reliability MTAI		
4b. Auto Clave	Stress Condition: 1) for SMD,MSL pre-conditioned prior to test 2) 121C/100%RH / 15PSIG / 168 hrs Electrical Test: Post test at Supertex HK	JESD22- A102D	45 (0)	0/45	Pass	Test Location: Supertex Hongkong		
4c. Thermal Shock	Stress Condition: 1) for SMD,MSL pre-conditioned prior to test 2) Cond B:-55 to 125C / 200 cyc Electrical Test: Post test at Supertex HK	MIL-STD- 883HM1011.9	45(0)	0/45	Pass	Test Location: Supertex Hongkong		
4d.Temperature Cycling	Stress Condition: 1) for SMD,MSL pre-conditioned prior to test 2) Cond C:-65 to 150C / 500 cyc Electrical Test: Post test at Supertex HK	MIL-STD- 883HM1010.8	45(0)	0/45	Pass	Test Location: Reliability MTAI		
4e. Temperature Humidity Bias	Stress Condition: 1) for SMD,MSL pre-conditioned prior to test 2) biased @ 85C / 85%RH for 168 / 500 1000 hrs Electrical Test: Post test at Supertex HK	JESD22- A101C	45(0)	0/45	Pass	Test Location: Supertex Sunnyvale USA		